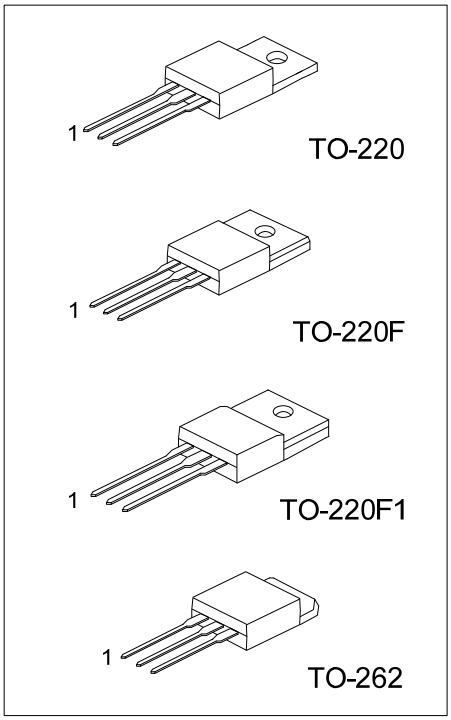
8N60

Power MOSFET

7.5 Amps, 600/650 Volts
N-CHANNEL POWER MOSFET



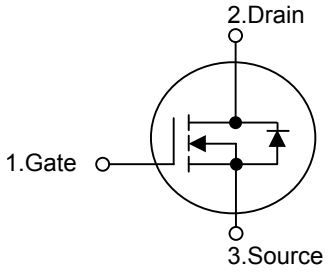
■ DESCRIPTION

The UTC **8N60** is a high voltage and high current power MOSFET, designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

* $R_{DS(ON)}$ = 1.2Ω@V_{GS} = 10 V
* Ultra low gate charge (typical 28 nC)
* Low reverse transfer capacitance (C_{RSS} = typical 12.0 pF)
* Fast switching capability
* Avalanche energy specified
* Improved dv/dt capability, high ruggedness

■ SYMBOL



■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
8N60L-x-TA3-T	8N60G-x-TA3-T	TO-220	G	D	S	Tube
8N60L-x-TF1-T	8N60G-x-TF1-T	TO-220F1	G	D	S	Tube
8N60L-x-TF3-T	8N60G-x-TF3-T	TO-220F	G	D	S	Tube
8N60L-x-T2Q-T	8N60G-x-T2Q-T	TO-262	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

8N60L-x-TA3-T (1)Packing Type (2)Package Type (3)Drain-Source Voltage (4)Lead Plating	(1) T: Tube (2) TA3: TO-220, TF1: TO220-F1, TF3: TO-220F T2Q: TO-262 (3) A: 600V, B: 650V (4) G: Halogen Free, L: Lead Free

■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage	8N60-A	V_{DSS}	600	V
	8N60-B		650	V
Gate-Source Voltage		V_{GSS}	±30	V
Avalanche Current (Note 2)		I_{AR}	7.5	A
Drain Current	Continuous	I_D	7.5	A
	Pulsed (Note 2)	I_{DM}	30	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	230	mJ
	Repetitive (Note 2)	E_{AR}	14.7	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
Power Dissipation	TO-220/TO-262	P_D	147	W
	TO-220F/TO-220F1		48	W
Junction Temperature		T_J	+150	°C
Operating Temperature		T_{OPR}	-55 ~ +150	°C
Storage Temperature		T_{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating : Pulse width limited by T_J
3. L = 7.3mH, I_{AS} = 7.5A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C
4. I_{SD} ≤7.5A, di/dt ≤200A/μs, V_{DD}≤ BV_{DSS}, Starting T_J = 25°C

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient	TO-220/TO-262	θ_{JA}	62.5	°C/W
	TO-220F/TO-220F1		62.5	°C/W
Junction to Case	TO-220/TO-262	θ_{JC}	0.85	°C/W
	TO-220F/TO-220F1		2.6	°C/W

■ ELECTRICAL CHARACTERISTICS (T_C =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	8N60-A	BV_{DSS}	V_{GS} = 0 V, I_D = 250 μA	600			V
	8N60-B			650			V
Drain-Source Leakage Current		I_{DSS}	V_{DS} = 600 V, V_{GS} = 0 V			10	μA
Gate-Source Leakage Current	Forward	I_{GSS}	V_{GS} = 30 V, V_{DS} = 0 V			100	nA
	Reverse		V_{GS} = -30 V, V_{DS} = 0 V			-100	nA
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_J$	I_D = 250 μA, Referenced to 25°C		0.7		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	V_{DS} = V_{GS}, I_D = 250 μA	2.0		4.0	V
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	V_{GS} = 10 V, I_D = 3.75 A		1.0	1.2	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C_{ISS}	V_{DS} = 25 V, V_{GS} = 0 V, f = 1MHz		965	1255	pF
Output Capacitance		C_{OSS}			105	135	pF
Reverse Transfer Capacitance		C_{RSS}			12	16	pF
SWITCHING CHARACTERISTICS							
Turn-On Delay Time		$t_{D(ON)}$	V_{DD} = 300V, I_D = 7.5 A, R_G = 25Ω (Note 1, 2)		16.5	45	ns
Turn-On Rise Time		t_R			60.5	130	ns
Turn-Off Delay Time		$t_{D(OFF)}$			81	170	ns
Turn-Off Fall Time		t_F			64.5	140	ns
Total Gate Charge		Q_G	V_{DS}= 480V,I_D= 7.5A, V_{GS}= 10 V (Note 1, 2)		28	36	nC
Gate-Source Charge		Q_{GS}			4.5		nC
Gate-Drain Charge		Q_{GD}			12		nC

■ ELECTRICAL CHARACTERISTICS(Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Drain-Source Diode Forward Voltage	V_{SD}	V_{GS} = 0 V, I_S = 7.5 A			1.4	V
Maximum Continuous Drain-Source Diode Forward Current	I_S				7.5	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				30	A
Reverse Recovery Time	t_{RR}	V_{GS} = 0 V, I_S = 7.5 A,		365		ns
Reverse Recovery Charge	Q_{RR}	dI_F/dt = 100 A/μs (Note 2)		3.4		μC

Notes: 1. Pulse Test: Pulse width ≤300μs, Duty cycle≤2%
2. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

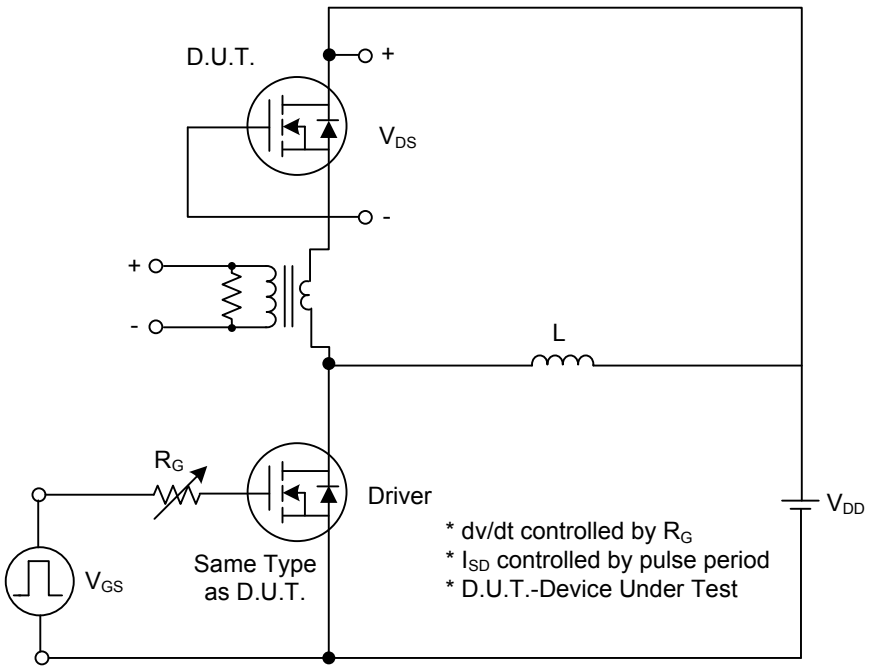


Fig. 1A Peak Diode Recovery dv/dt Test Circuit

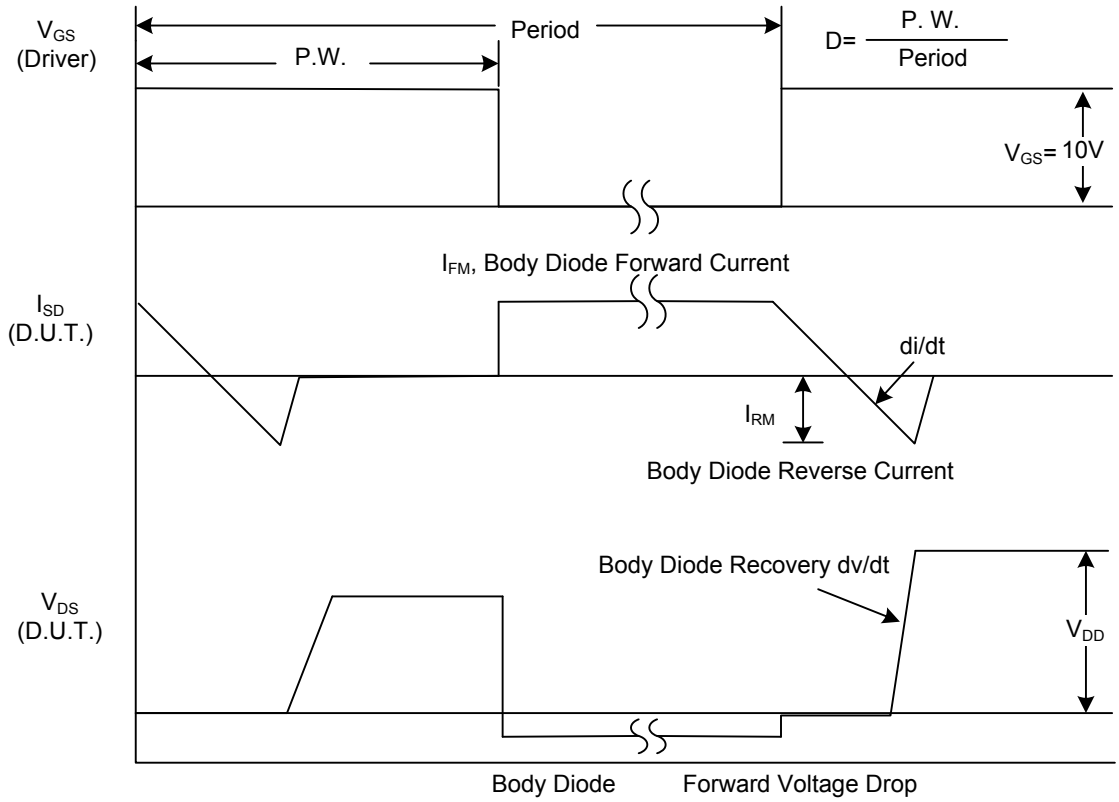


Fig. 1B Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)

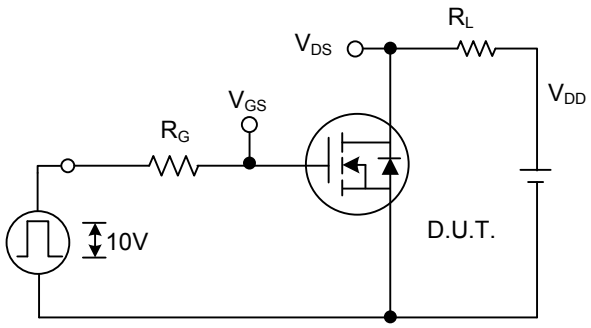


Fig. 2A Switching Test Circuit

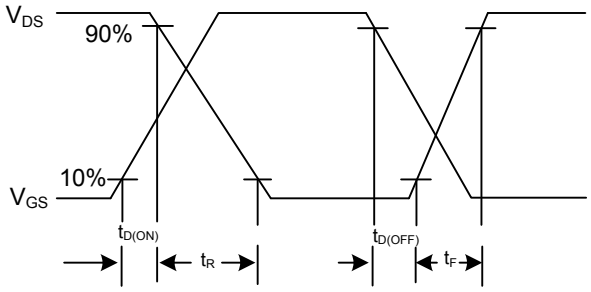


Fig. 2B Switching Waveforms

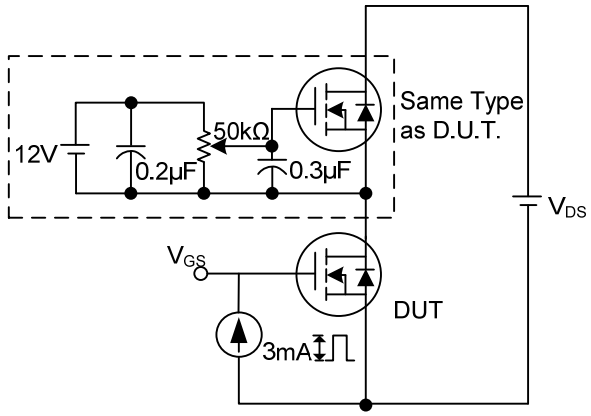


Fig. 3A Gate Charge Test Circuit

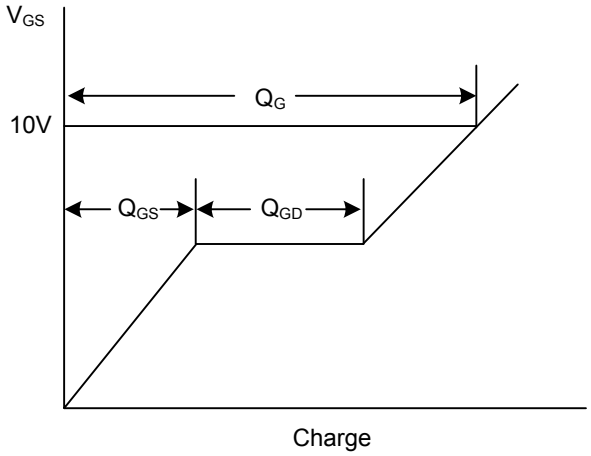


Fig. 3B Gate Charge Waveform

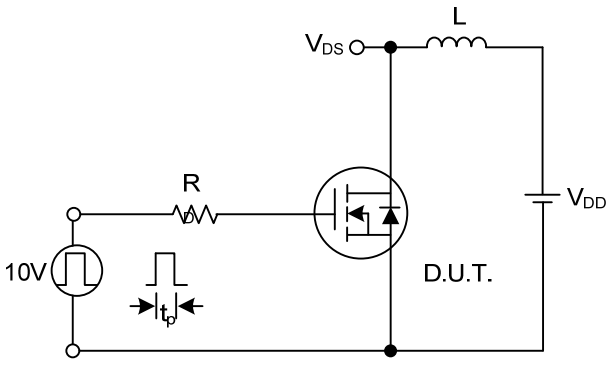


Fig. 4A Unclamped Inductive Switching Test Circuit

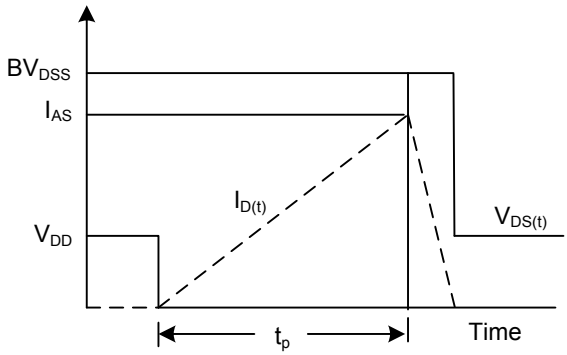
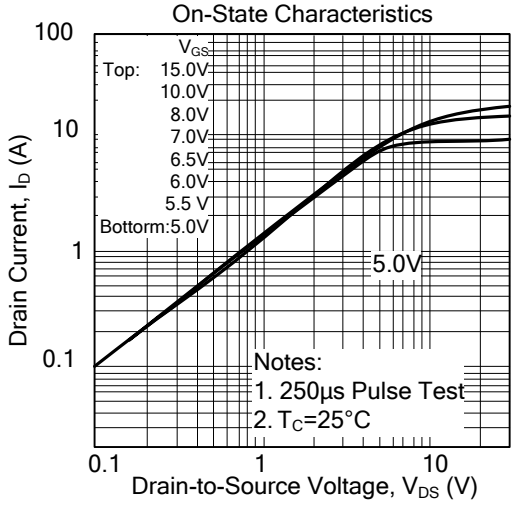


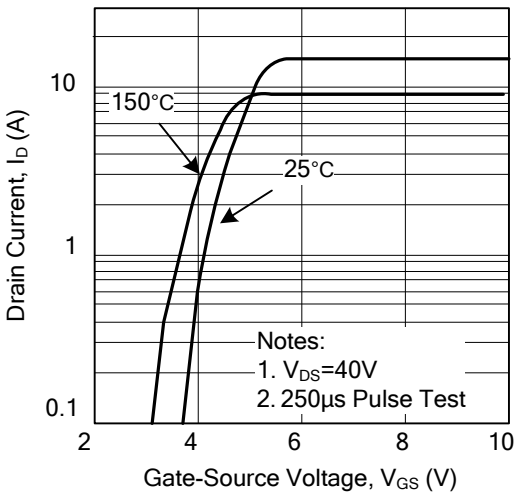
Fig. 4B Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS

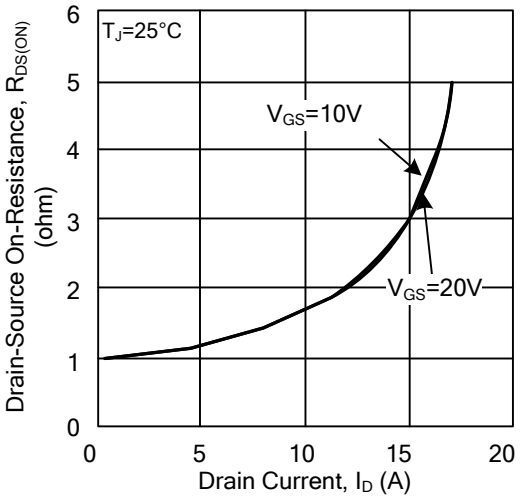
On-State Characteristics



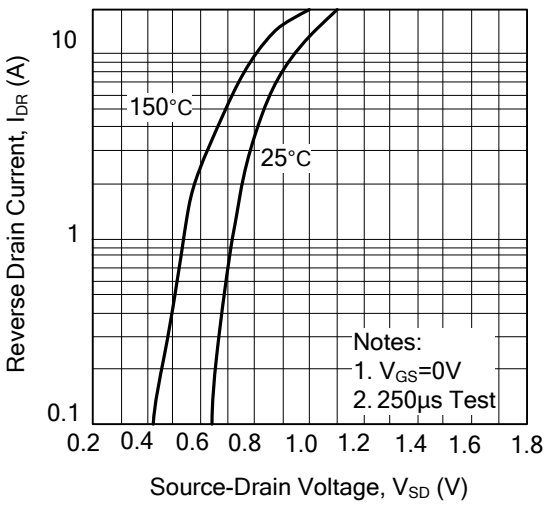
Transfer Characteristics



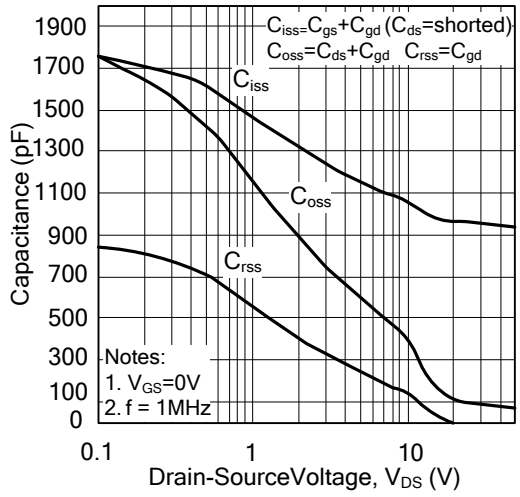
On-Resistance Variation vs. Drain Current and Gate Voltage



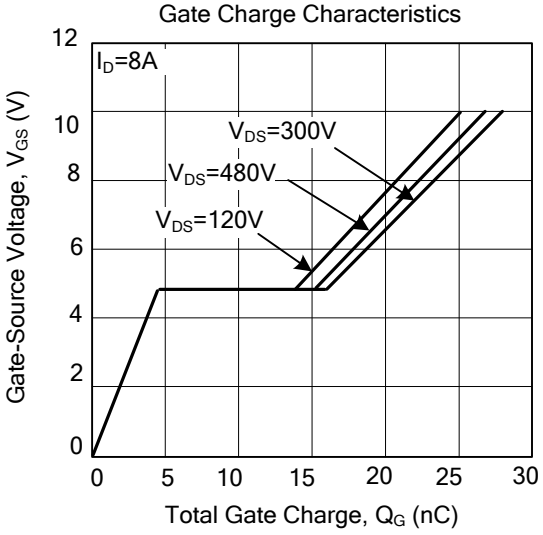
Body Diode Forward Voltage vs. Source Current



Capacitance Characteristics (Non-Repetitive)

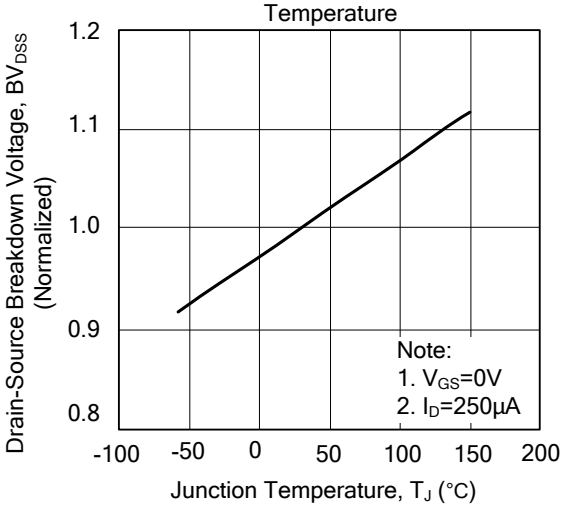


Gate Charge Characteristics

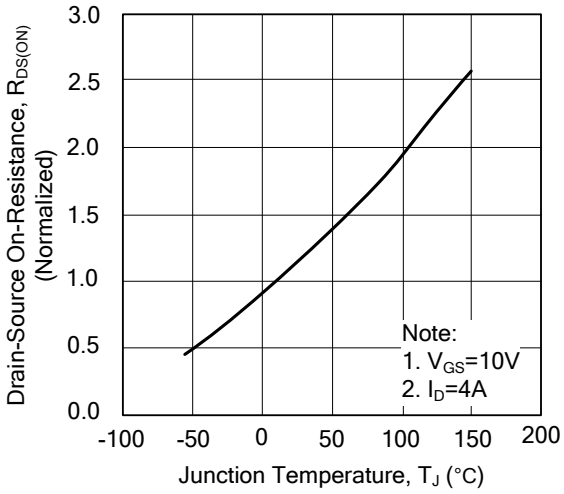


■ TYPICAL CHARACTERISTICS(Cont.)

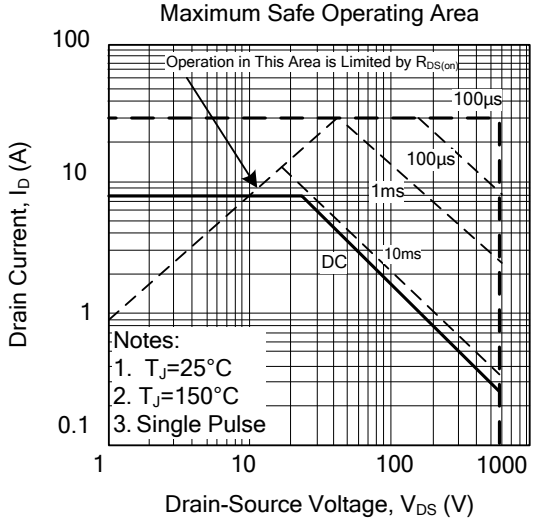
Breakdown Voltage Variation vs. Temperature



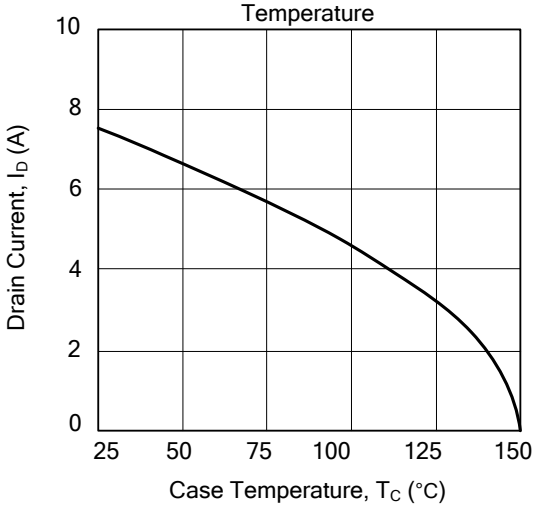
On-Resistance Junction Temperature



Maximum Safe Operating Area



Maximum Drain Current vs. Case Temperature



Transient Thermal Response Curve